

<b>Notice of References Cited</b>	Application/Control No. 10/772,625	Applicant(s)/Patent Under Reexamination OWEN ET AL.	
	Examiner Farhan M. Syed	Art Unit 2165	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-7,020,641 B2	03-2006	Leong et al.	706/12
*	C	US-7,058,958 B1	06-2006	Shutt et al.	719/328
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	K	US-			
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	M	US-			

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**NON-PATENT DOCUMENTS**

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